

Search Notes

Application/Control No.

10/540,407

Examiner

Benny Lee

Applicant(s)/Patent under
Reexamination

LO HINE TONG ET AL.

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
333	208,209, 210,212, 248	1/12/2007	BTL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR